Diode Semiconductor Device - Page 1 of 1



View Online at https://aerobasegroup.com/nsn/5961-01-318-9265

End Application:

Mesp

Criticality Code Justification:

Feat

Semiconductor Material:

Silicon

Special Features:

Selected from p/n jantxv1n4150-1; jantx1n4150-1; fscm 81349; hardness critical item

Nuclear Hardness Critical Feature:

Hardened

Test Data Document:

63812-8856220 specification (includes engineering type bulletins, brochures, etc., that reflect specification type data in specification format; excludes commercial catalogs, industry directories, and similar trade publications, reflecting general type data on certain environmental and performance requirements and test conditions that are shown as "typical", "average", "", etc.).

Shelf Life:

N/a

Unit Of Measure:

Demilitarization:

No

Fiig:

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